

LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/  
LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER

**GENERAL DESCRIPTION**

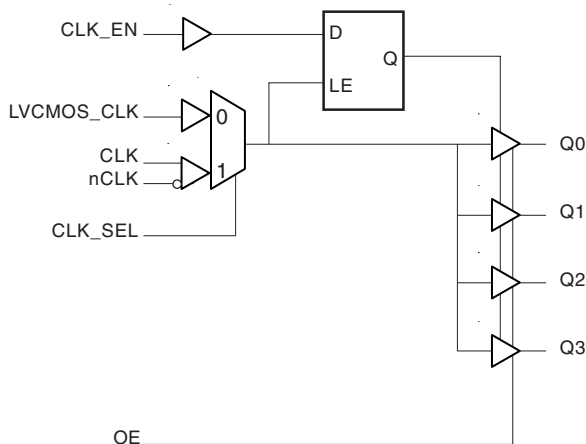
The ICS8305I is a low skew, 1-to-4, Differential/LVCMOS-to-LVCMOS/LVTTL Fanout Buffer. The ICS8305I has selectable clock inputs that accept either differential or single ended input levels. The clock enable is internally synchronized to eliminate runt pulses on the outputs during asynchronous assertion/deassertion of the clock enable pin. Outputs are forced LOW when the clock is disabled. A separate output enable pin controls whether the outputs are in the active or high impedance state.

Guaranteed output and part-to-part skew characteristics make the ICS8305I ideal for those applications demanding well defined performance and repeatability.

**FEATURES**

- 4 LVCMOS/LVTTL outputs
- Selectable differential or LVCMOS/LVTTL clock inputs
- CLK, nCLK pair can accept the following differential input levels: LVPECL, LVDS, LVHSTL, HCSL, SSTL
- LVCMOS\_CLK supports the following input types: LVCMOS, LVTTL
- Maximum output frequency: 350MHz
- Output skew: 40ps (maximum)
- Part-to-part skew: 700ps (maximum)
- Additive phase jitter, RMS: 0.04ps (typical)
- 3.3V core, 3.3V, 2.5V or 1.8V output operating supply
- -40°C to 85°C ambient operating temperature
- Lead-Free package fully RoHS compliant

**BLOCK DIAGRAM**



**PIN ASSIGNMENT**

|            |   |    |      |
|------------|---|----|------|
| GND        | 1 | 16 | Q0   |
| OE         | 2 | 15 | VDD0 |
| VDD        | 3 | 14 | Q1   |
| CLK_EN     | 4 | 13 | GND  |
| CLK        | 5 | 12 | Q2   |
| nCLK       | 6 | 11 | VDD0 |
| CLK_SEL    | 7 | 10 | Q3   |
| LVCMOS_CLK | 8 | 9  | GND  |

**ICS8305I**  
**16-Lead TSSOP**  
 4.4mm x 3.0mm x 0.92mm package body  
**G Package**  
 Top View

**TABLE 1. PIN DESCRIPTIONS**

| Number         | Name             | Type   |                     | Description  |
|----------------|------------------|--------|---------------------|--|
| 1, 9, 13       | GND              | Power  |                     | Power supply ground.   |
| 2              | OE               | Input  | Pullup              | Output enable. When LOW, outputs are in HIGH impedance state. When HIGH, outputs are active. LVCMOS / LVTTL interface levels.                |
| 3              | V <sub>DD</sub>  | Power  |                     | Core supply pin.   |
| 4              | CLK_EN           | Input  | Pullup              | Synchronizing clock enable. When LOW, the output clocks are disabled. When HIGH, output clocks are enabled. LVCMOS / LVTTL interface levels. |
| 5              | CLK              | Input  | Pulldown            | Non-inverting differential clock input.  |
| 6              | nCLK             | Input  | Pullup/<br>Pulldown | Inverting differential clock input. V <sub>DD</sub> /2 default when left floating.   |
| 7              | CLK_SEL          | Input  | Pullup              | Clock select input. When HIGH, selects CLK, nCLK inputs. When LOW, selects LVCMOS_CLK input. LVCMOS / LVTTL interface levels.                |
| 8              | LVCMOS_CLK       | Input  | Pulldown            | LVCMOS / LVTTL clock input.  |
| 10, 12, 14, 16 | Q3, Q2, Q1, Q0   | Output |                     | Clock outputs. LVCMOS / LVTTL interface levels.  |
| 11, 15         | V <sub>DDO</sub> | Power  |                     | Output supply pins.  |

NOTE: *Pullup* and *Pulldown* refer to internal input resistors. See Table 2, Pin Characteristics, for typical values.

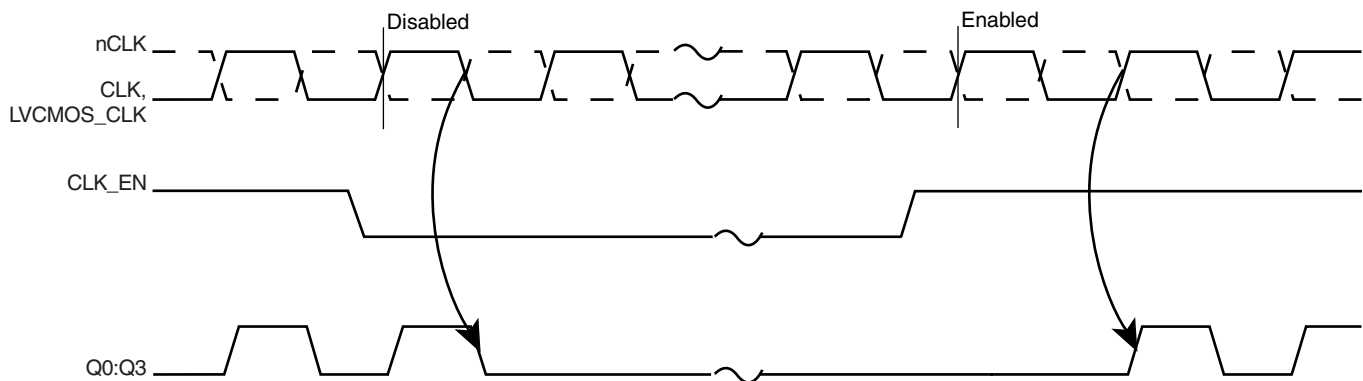
**TABLE 2. PIN CHARACTERISTICS**

| Symbol                | Parameter                                  | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------------------|--|-----------------|---------|---------|---------|-------|
| C <sub>IN</sub>       | Input Capacitance                          |                 |         | 4       |         | pF    |
| R <sub>PULLUP</sub>   | Input Pullup Resistor                      |                 |         | 51      |         | kΩ    |
| R <sub>PULLDOWN</sub> | Input Pulldown Resistor                    |                 |         | 51      |         | kΩ    |
| C <sub>PD</sub>       | Power Dissipation Capacitance (per output) |                 |         | 11      |         | pF    |
| R <sub>OUT</sub>      | Output Impedance                           |                 | 5       | 7       | 12      | Ω     |

**TABLE 3A. CONTROL INPUT FUNCTION TABLE**

| Inputs |        |         | Outputs       |
|--------|--------|---------|---------------|
| OE     | CLK_EN | CLK_SEL | Q0:Q3         |
| 1      | 0      | 0       | Disabled; LOW |
| 1      | 0      | 1       | Disabled; LOW |
| 1      | 1      | 0       | Enabled       |
| 1      | 1      | 1       | Enabled       |
| 0      | X      | X       | HiZ           |

NOTE: After CLK\_EN switches, the clock outputs are disabled or enabled following a rising and falling input clock edge as shown in Figure 1.



**FIGURE 1. CLK\_EN TIMING DIAGRAM**

## LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/ LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER

### ABSOLUTE MAXIMUM RATINGS

|  |                           |
|--|---------------------------|
| Supply Voltage, $V_{DD}$                 | 4.6V                      |
| Inputs, $V_I$                            | -0.5V to $V_{DD} + 0.5V$  |
| Outputs, $V_O$                           | -0.5V to $V_{DDO} + 0.5V$ |
| Package Thermal Impedance, $\theta_{JA}$ | 89°C/W (0 lfpm)           |
| Storage Temperature, $T_{STG}$           | -65°C to 150°C            |

NOTE: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

**TABLE 4A. POWER SUPPLY DC CHARACTERISTICS,  $V_{DD} = 3.3V \pm 5\%$ ,  $T_A = -40^\circ C$  TO  $85^\circ C$**

| Symbol    | Parameter             | Test Conditions | Minimum | Typical | Maximum | Units |
|-----------|-----------------------|-----------------|---------|---------|---------|-------|
| $V_{DD}$  | Core Supply Voltage   |                 | 3.135   | 3.3     | 3.465   | V     |
| $V_{DDO}$ | Output Supply Voltage |                 | 3.135   | 3.3     | 3.465   | V     |
|           |                       |                 | 2.375   | 2.5     | 2.625   | V     |
|           |                       |                 | 1.65    | 1.8     | 1.95    | V     |
| $I_{DD}$  | Power Supply Current  |                 |         | 21      | mA      |       |
| $I_{DDO}$ | Output Supply Current |                 |         | 5       | mA      |       |

**TABLE 4B. LVCMOS/LVTTL DC CHARACTERISTICS,  $V_{DD} = 3.3V \pm 5\%$ ,  $T_A = -40^\circ C$  TO  $85^\circ C$**

| Symbol    | Parameter                    | Test Conditions     | Minimum                        | Typical         | Maximum        | Units   |
|-----------|------------------------------|---------------------|--------------------------------|-----------------|----------------|---------|
| $V_{IH}$  | Input High Voltage           | CLK_EN, CLK_SEL, OE |                                | 2               | $V_{DD} + 0.3$ | V       |
|           |                              | LVCMOS_CLK          |                                | 2               | $V_{DD} + 0.3$ | V       |
| $V_{IL}$  | Input Low Voltage            | CLK_EN, CLK_SEL, OE |                                | -0.3            | 0.8            | V       |
|           |                              | LVCMOS_CLK          |                                | -0.3            | 1.3            | V       |
| $I_{IH}$  | Input High Current           | CLK_EN, CLK_SEL, OE | $V_{DD} = V_{IN} = 3.465V$     |                 | 5              | $\mu A$ |
|           |                              | LVCMOS_CLK          | $V_{DD} = V_{IN} = 3.465V$     |                 | 150            | $\mu A$ |
| $I_{IL}$  | Input Low Current            | CLK_EN, CLK_SEL, OE | $V_{DD} = 3.465V, V_{IN} = 0V$ | -150            |                | $\mu A$ |
|           |                              | LVCMOS_CLK          | $V_{DD} = 3.465V, V_{IN} = 0V$ | -5              |                | $\mu A$ |
| $V_{OH}$  | Output High Voltage; NOTE 1  |                     | $V_{DDO} = 3.3V \pm 5\%$       | 2.6             |                | V       |
|           |                              |                     | $V_{DDO} = 2.5V \pm 5\%$       | 1.8             |                | V       |
|           |                              |                     | $V_{DDO} = 1.8V \pm 0.15V$     | $V_{DDO} - 0.3$ |                | V       |
| $V_{OL}$  | Output Low Voltage; NOTE 1   |                     | $V_{DDO} = 3.3V \pm 5\%$       |                 | 0.5            | V       |
|           |                              |                     | $V_{DDO} = 2.5V \pm 5\%$       |                 | 0.5            | V       |
|           |                              |                     | $V_{DDO} = 1.8V \pm 0.15V$     |                 | 0.4            | V       |
| $I_{OZL}$ | Output Tristate Current Low  |                     | -5                             |                 | $\mu A$        |         |
| $I_{OZH}$ | Output Tristate Current High |                     |                                |                 | 5              | $\mu A$ |

NOTE 1: Outputs terminated with  $50\Omega$  to  $V_{DDO}/2$ . See Parameter Measurement Information, Output Load Test Circuit.

## LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/ LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER

**TABLE 4C. DIFFERENTIAL DC CHARACTERISTICS,  $V_{DD} = 3.3V \pm 5\%$ ,  $T_A = -40^\circ\text{C}$  TO  $85^\circ\text{C}$**

| Symbol    | Parameter                               | Test Conditions | Minimum                        | Typical | Maximum         | Units         |
|-----------|---|-----------------|--------------------------------|---------|-----------------|---------------|
| $I_{IH}$  | Input High Current                      | nCLK            | $V_{IN} = V_{DD} = 3.465V$     |         | 150             | $\mu\text{A}$ |
|           |   | CLK             | $V_{IN} = V_{DD} = 3.465V$     |         | 150             | $\mu\text{A}$ |
| $I_{IL}$  | Input Low Current                       | nCLK            | $V_{IN} = 0V, V_{DD} = 3.465V$ | -150    |                 | $\mu\text{A}$ |
|           |   | CLK             | $V_{IN} = 0V, V_{DD} = 3.465V$ | -5      |                 | $\mu\text{A}$ |
| $V_{PP}$  | Peak-to-Peak Input Voltage              |                 | 0.15                           |         | 1.3             | V             |
| $V_{CMR}$ | Common Mode Input Voltage;<br>NOTE 1, 2 |                 | GND + 0.5                      |         | $V_{DD} - 0.85$ | V             |

NOTE 1: For single ended applications, the maximum input voltage for CLK, nCLK is  $V_{DD} + 0.3V$ .

NOTE 2: Common mode voltage is defined as  $V_{IH}$ .

**TABLE 5A. AC CHARACTERISTICS,  $V_{DD} = V_{DDO} = 3.3V \pm 5\%$ ,  $T_A = -40^\circ\text{C}$  TO  $85^\circ\text{C}$**

| Symbol      | Parameter   | Test Conditions                                 | Minimum | Typical | Maximum | Units |
|-------------|---|---|---------|---------|---------|-------|
| $f_{MAX}$   | Output Frequency  | Ref = CLK/nCLK                                  |         |         | 350     | MHz   |
|             |   | Ref = LVCMOS_CLK                                |         |         | 300     | MHz   |
| $tp_{LH}$   | Propagation Delay,<br>Low to High   | LVCMOS_CLK;<br>NOTE 1A<br>CLK, nCLK;<br>NOTE 1B | 1.75    |         | 2.8     | ns    |
| $tsk(o)$    | Output Skew; NOTE 2, 6  | Measured on the Rising Edge                     |         |         | 40      | ps    |
| $tsk(pp)$   | Part-to-Part Skew; NOTE 3, 6  |   |         |         | 700     | ps    |
| $f_{jit}$   | Buffer Additive Phase Jitter, RMS;<br>refer to Additive Phase Jitter section,<br>NOTE 5 |   |         | 0.04    |         | ps    |
| $t_R / t_F$ | Output Rise/Fall Time   | 20% to 80%                                      | 100     |         | 700     | ps    |
| odc         | Output Duty Cycle   | $f \leq 200\text{MHz}$                          | 45      |         | 55      | %     |
|             |   | $f > 200\text{MHz}$                             | 42      |         | 58      | %     |
| $t_{EN}$    | Output Enable Time; NOTE 4  |   |         |         | 5       | ns    |
| $t_{DIS}$   | Output Disable Time; NOTE 4   |   |         |         | 5       | ns    |

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 1A: Measured from the  $V_{DD}/2$  of the input to  $V_{DDO}/2$  of the output.

NOTE 1B: Measured from the differential input crossing point to  $V_{DDO}/2$  of the output.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions.  
Measured at  $V_{DDO}/2$ .

NOTE 3: Defined as skew between outputs on different devices operating at the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at  $V_{DDO}/2$ .

NOTE 4: These parameters are guaranteed by characterization. Not tested in production.

NOTE 5: Driving only one input clock.

NOTE 6: This parameter is defined in accordance with JEDEC Standard 65.

## LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/ LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER

**TABLE 5B. AC CHARACTERISTICS,  $V_{DD} = 3.3V \pm 5\%$ ,  $V_{DDO} = 2.5V \pm 5\%$ ,  $T_A = -40^\circ C$  TO  $85^\circ C$**

| Symbol       | Parameter   | Test Conditions                                 | Minimum | Typical | Maximum | Units |
|--------------|---|---|---------|---------|---------|-------|
| $f_{MAX}$    | Output Frequency  | Ref = CLK/nCLK                                  |         |         | 350     | MHz   |
|              |   | Ref = LVCMOS_CLK                                |         |         | 300     | MHz   |
| $t_{pLH}$    | Propagation Delay, Low to High  | LVCMOS_CLK;<br>NOTE 1A<br>CLK, nCLK;<br>NOTE 1B | 1.75    |         | 2.95    | ns    |
| $t_{sk(o)}$  | Output Skew; NOTE 2, 6  | Measured on the Rising Edge                     |         |         | 40      | ps    |
| $t_{sk(pp)}$ | Part-to-Part Skew; NOTE 3, 6  |   |         |         | 800     | ps    |
| $t_{jit}$    | Buffer Additive Phase Jitter, RMS; refer to Additive Phase Jitter section, NOTE 5 |   |         | 0.04    |         | ps    |
| $t_R / t_F$  | Output Rise/Fall Time   | 20% to 80%                                      | 100     |         | 700     | ps    |
| odc          | Output Duty Cycle   | $f \leq 166MHz$                                 | 45      |         | 55      | %     |
|              |   | $f > 166MHz$                                    | 42      |         | 58      | %     |
| $t_{EN}$     | Output Enable Time; NOTE 4  |   |         |         | 5       | ns    |
| $t_{DIS}$    | Output Disable Time; NOTE 4   |   |         |         | 5       | ns    |

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 1A: Measured from the  $V_{DD}/2$  of the input to  $V_{DDO}/2$  of the output.

NOTE 1B: Measured from the differential input crossing point to  $V_{DDO}/2$  of the output.

NOTE 2: Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at  $V_{DDO}/2$ .

NOTE 3: Defined as skew between outputs on different devices operating at the same supply voltages and with equal load conditions. Using the same type of input on each device, the output is measured at  $V_{DDO}/2$ .

NOTE 4: These parameters are guaranteed by characterization. Not tested in production.

NOTE 5: Driving only one input clock.

NOTE 6: This parameter is defined in accordance with JEDEC Standard 65.

**TABLE 5C. AC CHARACTERISTICS,  $V_{DD} = 3.3V \pm 5\%$ ,  $V_{DDO} = 1.8V \pm 0.15V$ ,  $T_A = -40^\circ C$  TO  $85^\circ C$**

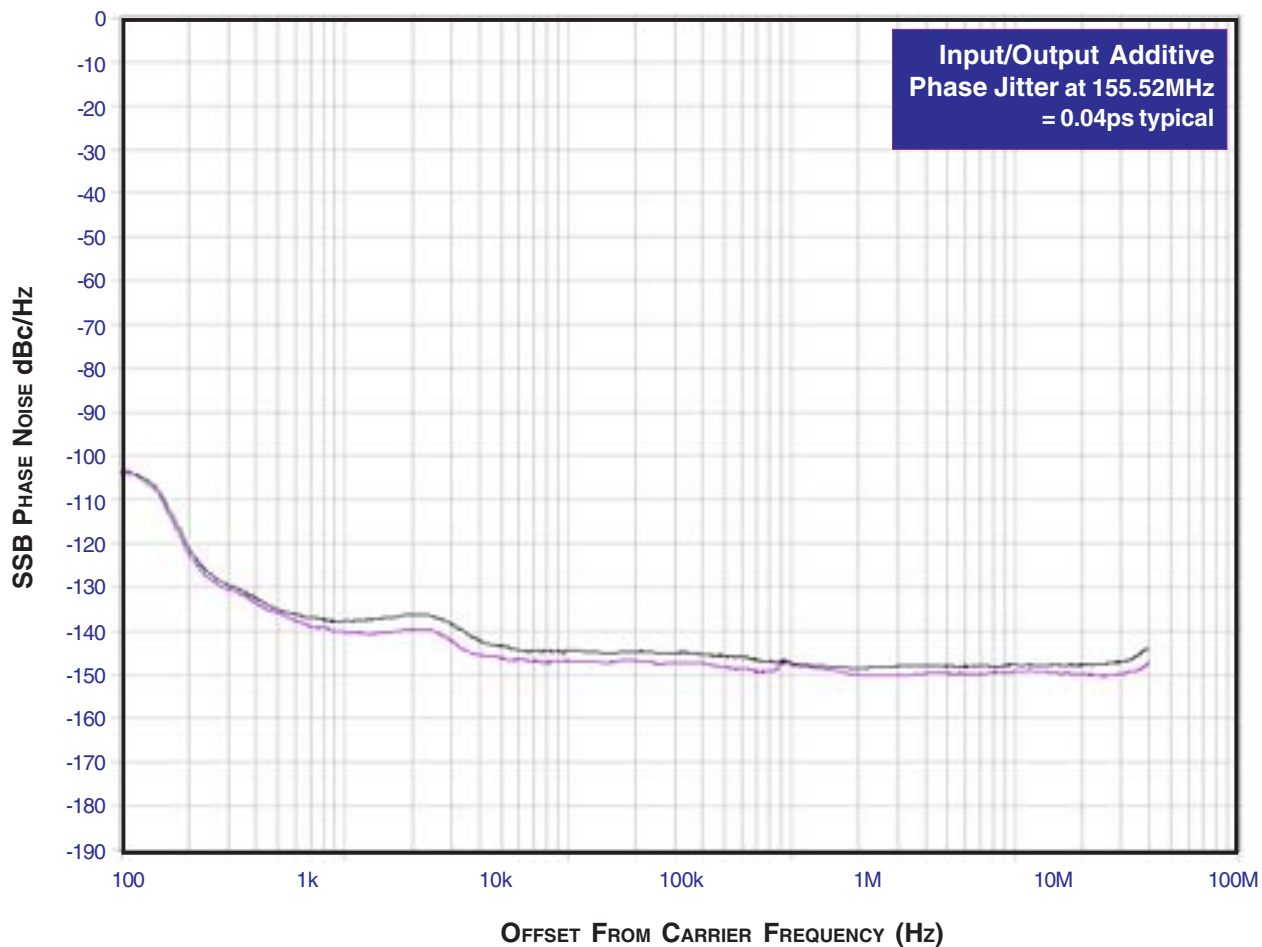
| Symbol       | Parameter   | Test Conditions                                 | Minimum | Typical | Maximum | Units |
|--------------|---|---|---------|---------|---------|-------|
| $f_{MAX}$    | Output Frequency  | Ref = CLK/nCLK                                  |         |         | 350     | MHz   |
|              |   | Ref = LVCMOS_CLK                                |         |         | 300     | MHz   |
| $t_{pLH}$    | Propagation Delay, Low to High  | LVCMOS_CLK;<br>NOTE 1A<br>CLK, nCLK;<br>NOTE 1B | 1.75    |         | 3.7     | ns    |
| $t_{sk(o)}$  | Output Skew; NOTE 2, 6  | Measured on the Rising Edge                     |         |         | 45      | ps    |
| $t_{sk(pp)}$ | Part-to-Part Skew; NOTE 3, 6  |   |         |         | 900     | ps    |
| $t_{jit}$    | Buffer Additive Phase Jitter, RMS; refer to Additive Phase Jitter section, NOTE 5 |   |         | 0.04    |         | ps    |
| $t_R / t_F$  | Output Rise/Fall Time   | 20% to 80%                                      | 100     |         | 700     | ps    |
| odc          | Output Duty Cycle   | $f \leq 166MHz$                                 | 45      |         | 55      | %     |
|              |   | $f > 166MHz$                                    | 42      |         | 58      | %     |
| $t_{EN}$     | Output Enable Time; NOTE 4  |   |         |         | 5       | ns    |
| $t_{DIS}$    | Output Disable Time; NOTE 4   |   |         |         | 5       | ns    |

For notes, see Table 5B.

### ADDITIVE PHASE JITTER

The spectral purity in a band at a specific offset from the fundamental compared to the power of the fundamental is called the **dBc Phase Noise**. This value is normally expressed using a Phase noise plot and is most often the specified plot in many applications. Phase noise is defined as the ratio of the noise power present in a 1Hz band at a specified offset from the fundamental frequency to the power value of the fundamental. This ratio is expressed in decibels (dBm) or a ratio of the power in

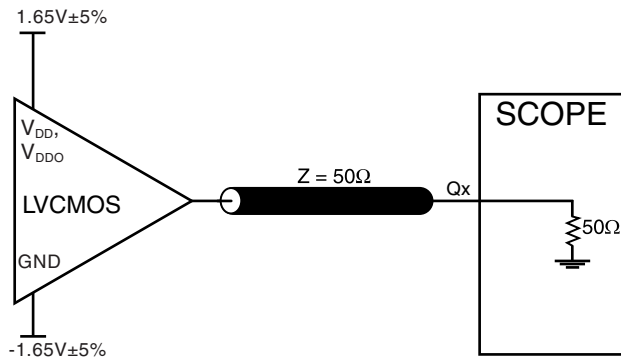
the 1Hz band to the power in the fundamental. When the required offset is specified, the phase noise is called a **dBc** value, which simply means dBm at a specified offset from the fundamental. By investigating jitter in the frequency domain, we get a better understanding of its effects on the desired application over the entire time record of the signal. It is mathematically possible to calculate an expected bit error rate given a phase noise plot.



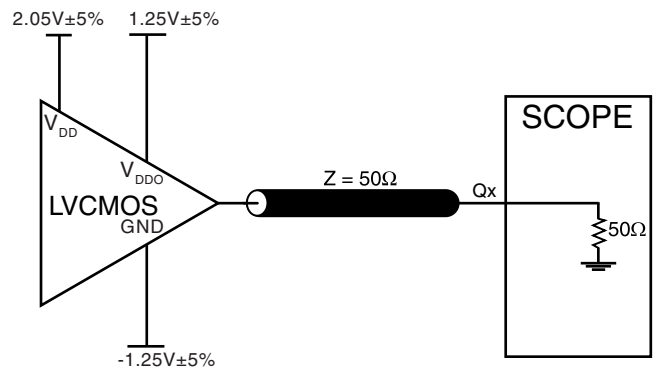
As with most timing specifications, phase noise measurements have issues. The primary issue relates to the limitations of the equipment. Often the noise floor of the equipment is higher than the noise floor of the device. This is illustrated above. The de-

vice meets the noise floor of what is shown, but can actually be lower. The phase noise is dependant on the input source and measurement equipment.

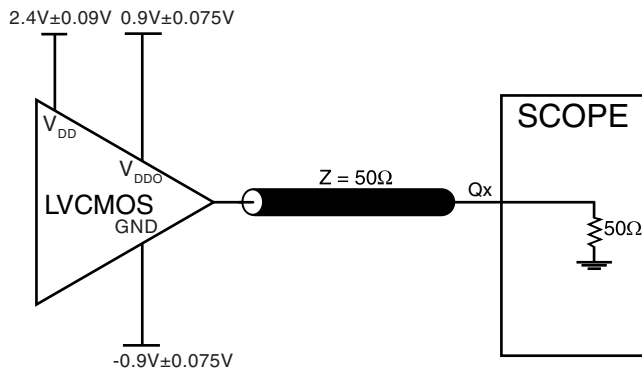
### PARAMETER MEASUREMENT INFORMATION



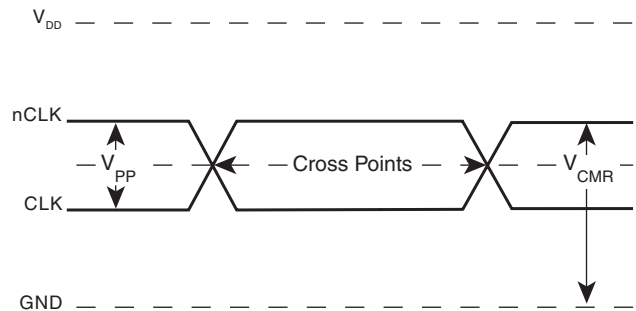
**3.3V CORE/3.3V OUTPUT LOAD AC TEST CIRCUIT**



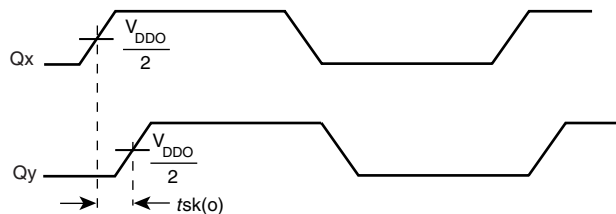
**3.3V CORE/2.5V OUTPUT LOAD AC TEST CIRCUIT**



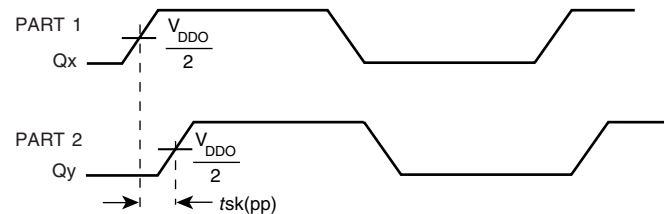
**3.3V CORE/1.8V OUTPUT LOAD AC TEST CIRCUIT**



**DIFFERENTIAL INPUT LEVEL**



**OUTPUT SKEW**

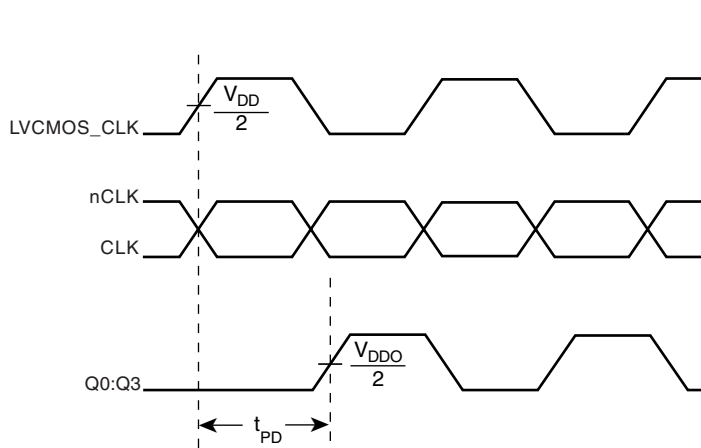


**PART-TO-PART SKEW**

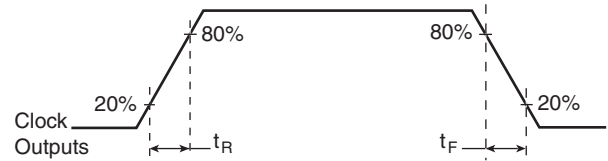


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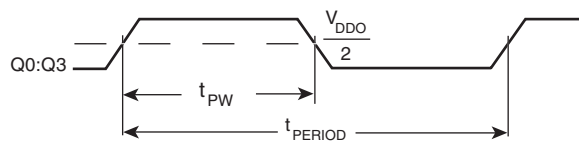
## LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/ LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER



**PROPAGATION DELAY**



**OUTPUT RISE/FALL TIME**



$$\text{odc} = \frac{t_{\text{PW}}}{t_{\text{PERIOD}}} \times 100\%$$

**OUTPUT DUTY CYCLE/PULSE WIDTH/PERIOD**

## APPLICATION INFORMATION

### RECOMMENDATION FOR UNUSED INPUT AND OUTPUT PINS

#### Inputs:

##### LVCMOS\_CLK Input

For applications not requiring the use of a clock input, it can be left floating. Though not required, but for additional protection, a 1k $\Omega$  resistor can be tied from the LVCMOS\_CLK input to ground.

##### CLK/nCLK Inputs

For applications not requiring the use of the differential input, both CLK and nCLK can be left floating. Though not required, but for additional protection, a 1k $\Omega$  resistor can be tied from CLK to ground.

##### LVCMOS Control Pins

All control pins have internal pull-ups or pull-downs; additional resistance is not required but can be added for additional protection. A 1k $\Omega$  resistor can be used.

#### Outputs:

##### LVCMOS Outputs

All unused LVCMOS outputs can be left floating. There should be no trace attached.

### WIRING THE DIFFERENTIAL INPUT TO ACCEPT SINGLE ENDED LEVELS

Figure 2 shows how a differential input can be wired to accept single ended levels. The reference voltage  $V_1 = V_{DD}/2$  is generated by the bias resistors R1 and R2. The bypass capacitor (C1) is used to help filter noise on the DC bias. This bias circuit should be located as close to the input pin as possible. The ratio of R1 and R2 might need to be adjusted to position the  $V_1$  in the center of the input voltage swing. For example, if the input clock swing is 2.5V and  $V_{DD} = 3.3V$ , R1 and R2 value should be adjusted to set  $V_1$  at 1.25V. The values below are for when both the single ended swing and  $V_{DD}$  are at the same voltage. This configuration requires that the sum of the output impedance of the driver ( $R_o$ ) and the series resistance ( $R_s$ ) equals the transmission line impedance. In addition, matched termination at the input will attenuate the signal in half. This can be done in one of two ways. First, R3 and R4 in parallel should equal the

transmission line impedance. For most 50 $\Omega$  applications, R3 and R4 can be 100 $\Omega$ . The values of the resistors can be increased to reduce the loading for slower and weaker LVCMOS driver. When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the differential input can handle full rail LVCMOS signaling, it is recommended that the amplitude be reduced. The datasheet specifies a lower differential amplitude, however this only applies to differential signals. For single-ended applications, the swing can be larger, however  $V_{IL}$  cannot be less than -0.3V and  $V_{IH}$  cannot be more than  $V_{DD} + 0.3V$ . Though some of the recommended components might not be used, the pads should be placed in the layout. They can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.

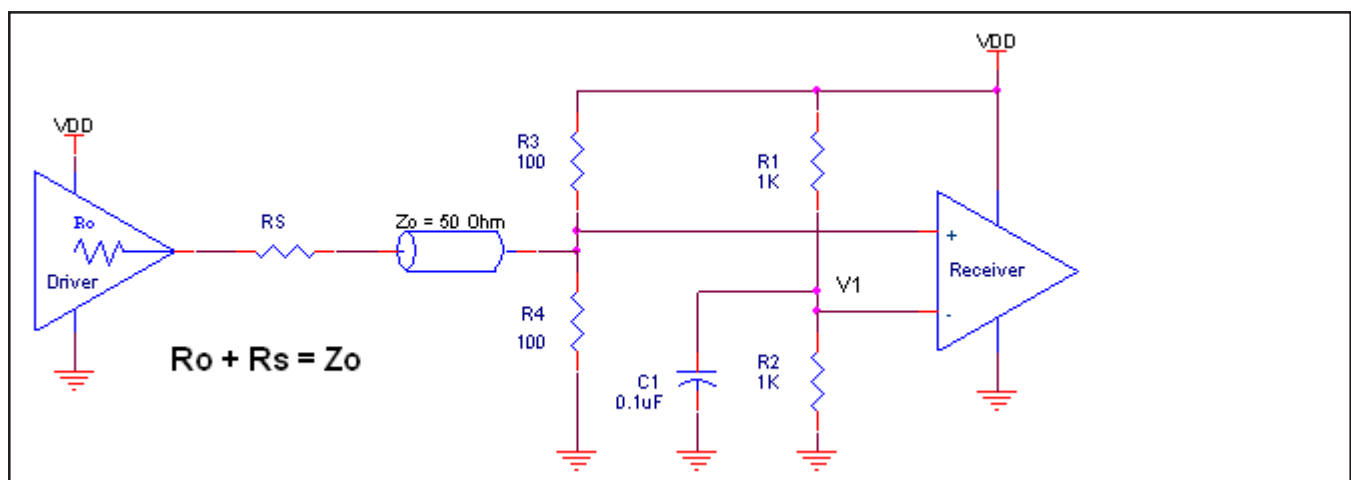


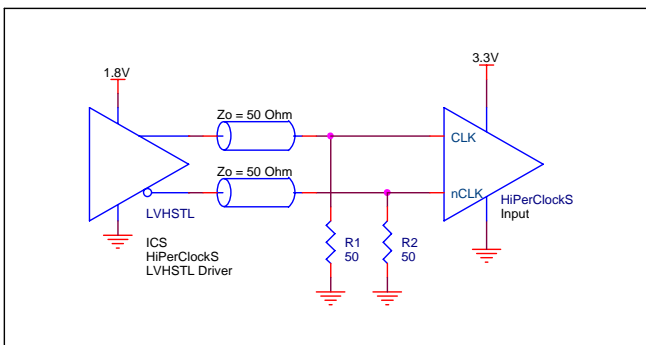
FIGURE 2. SINGLE ENDED SIGNAL DRIVING DIFFERENTIAL INPUT

## LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER

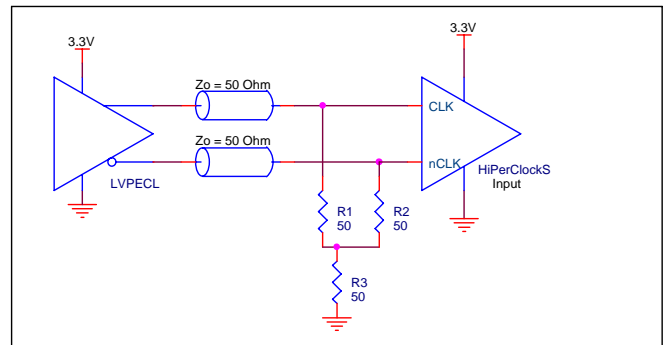
### DIFFERENTIAL CLOCK INPUT INTERFACE

The CLK/nCLK accepts LVDS, LVPECL, LVHSTL, SSTL, HCSL and other differential signals. Both  $V_{SWING}$  and  $V_{OH}$  must meet the  $V_{PP}$  and  $V_{CMR}$  input requirements. Figures 3A to 3E show interface examples for the CLK/nCLK input driven by the most common driver types. The input interfaces suggested here are

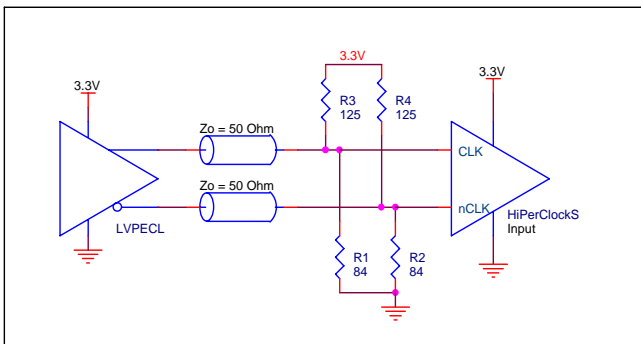
examples only. Please consult with the vendor of the driver component to confirm the driver termination requirements. For example in Figure 3A, the input termination applies for LVHSTL drivers. If you are using an LVHSTL driver from another vendor, use their termination recommendation.



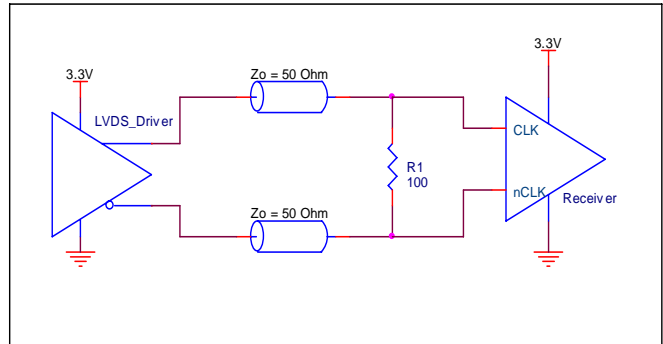
**FIGURE 3A. CLK/nCLK INPUT DRIVEN BY LVHSTL DRIVER**



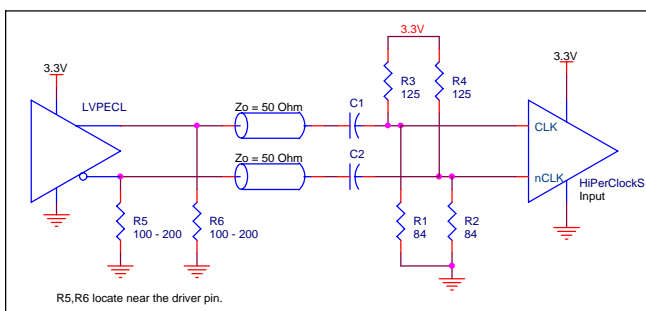
**FIGURE 3B. CLK/nCLK INPUT DRIVEN BY 3.3V LVPECL DRIVER**



**FIGURE 3C. CLK/nCLK INPUT DRIVEN BY 3.3V LVPECL DRIVER**



**FIGURE 3D. CLK/nCLK INPUT DRIVEN BY 3.3V LVDS DRIVER**



**FIGURE 3E. CLK/nCLK INPUT DRIVEN BY 3.3V LVPECL DRIVER WITH AC COUPLE**

### SCHEMATIC EXAMPLE

This application note provides general design guide using ICS8305I LVCMOS buffer. Figure 4 shows a schematic example of the ICS8305I LVCMOS clock buffer. In this example, the input

is driven by an LVCMOS driver. CLK\_EN is set at logic low to select LVCMOS\_CLK input.

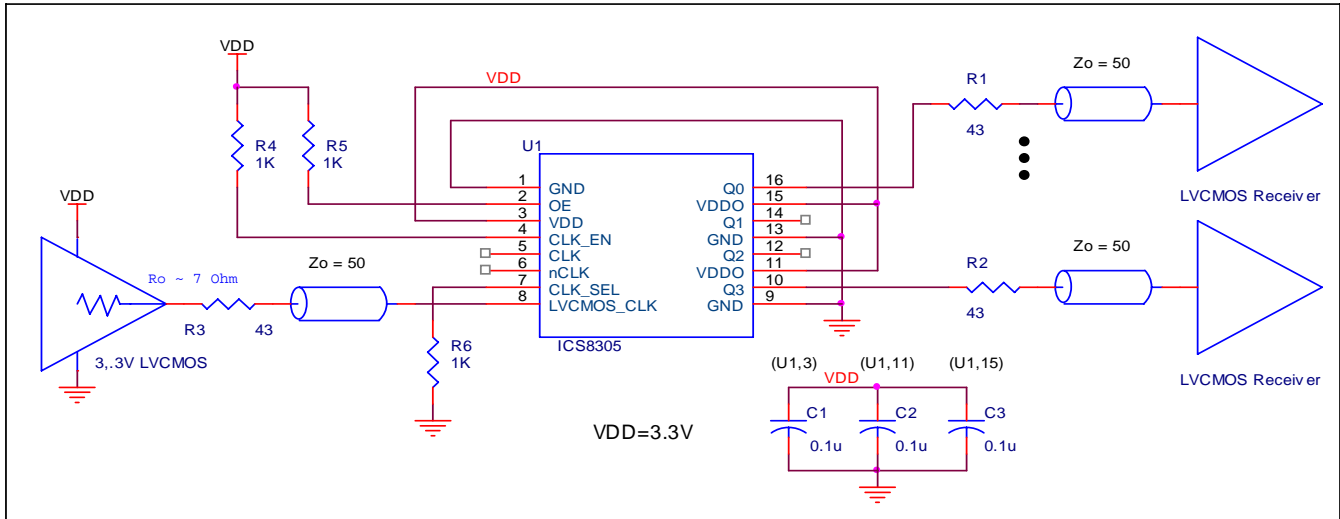


FIGURE 4. EXAMPLE ICS8305I LVCMOS CLOCK OUTPUT BUFFER SCHEMATIC

## RELIABILITY INFORMATION

TABLE 6.  $\theta_{JA}$  vs. AIR FLOW TABLE FOR 16 LEAD TSSOP

| $\theta_{JA}$ by Velocity (Linear Feet per Minute) |           |           |           |
|--|-----------|-----------|-----------|
|  | 0         | 200       | 500       |
| Single-Layer PCB, JEDEC Standard Test Boards       | 137.1°C/W | 118.2°C/W | 106.8°C/W |
| Multi-Layer PCB, JEDEC Standard Test Boards        | 89.0°C/W  | 81.8°C/W  | 78.1°C/W  |

**NOTE:** Most modern PCB designs use multi-layered boards. The data in the second row pertains to most designs.

### TRANSISTOR COUNT

The transistor count for ICS8305I is: 459

### PACKAGE OUTLINE - G SUFFIX FOR 16 LEAD TSSOP

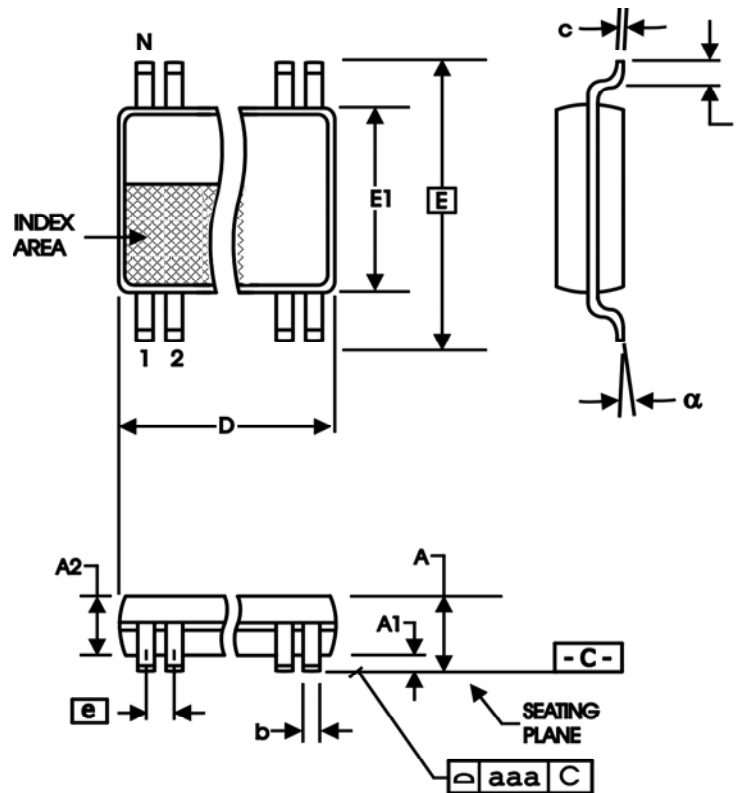


TABLE 7. PACKAGE DIMENSIONS

| SYMBOL | Millimeters |         |
|--------|-------------|---------|
|        | Minimum     | Maximum |
| N      | 16          |         |
| A      | --          | 1.20    |
| A1     | 0.05        | 0.15    |
| A2     | 0.80        | 1.05    |
| b      | 0.19        | 0.30    |
| c      | 0.09        | 0.20    |
| D      | 4.90        | 5.10    |
| E      | 6.40 BASIC  |         |
| E1     | 4.30        | 4.50    |
| e      | 0.65 BASIC  |         |
| L      | 0.45        | 0.75    |
| α      | 0°          | 8°      |
| aaa    | --          | 0.10    |

Reference Document: JEDEC Publication 95, MO-153

# ICS8305I

## LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/ LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER

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**TABLE 8. ORDERING INFORMATION**

| <b>Part/Order Number</b> | <b>Marking</b> | <b>Package</b>            | <b>Shipping Packaging</b> | <b>Temperature</b> |
|--------------------------|----------------|---------------------------|---------------------------|--------------------|
| 8305AGI                  | 8305AGI        | 16 Lead TSSOP             | tube                      | -40°C to 85°C      |
| 8305AGIT                 | 8305AGI        | 16 Lead TSSOP             | tape & reel               | -40°C to 85°C      |
| 8305AGILF                | 8305AGIL       | 16 Lead "Lead-Free" TSSOP | tube                      | -40°C to 85°C      |
| 8305AGILFT               | 8305AGIL       | 16 Lead "Lead-Free" TSSOP | tape & reel               | -40°C to 85°C      |

# ICS8305I

## LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/ LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER

| REVISION HISTORY SHEET |           |            |  |         |
|------------------------|-----------|------------|--|---------|
| Rev                    | Table     | Page       | Description of Change  | Date    |
| A                      | T8        | 14         | Ordering Information table - corrected Part/Order Number typo from ICS88305AGIT to ICS8305AGIT.                                  | 1/20/04 |
| B                      | T5A - T5C | 5 & 6<br>7 | AC Characteristics Tables - changed tjit from 0.05ps typical to 0.04ps typical.<br>Updated Additive Phase Jitter plot.           | 2/26/04 |
| B                      | T1        | 2          | Pin Description Table - corrected CLK_EN description.  | 12/7/04 |
| B                      | T8        | 14         | Ordering Information Table - added Lead-Free part number   | 5/19/05 |
| B                      | T8        | 14<br>16   | Updated datasheet's header/footer with IDT from ICS.<br>Removed ICS prefix from Part/Order Number column.<br>Added Contact Page. | 7/29/10 |
| B                      | T5A, T5B  | 5 & 6      | AC Characteristics Tables - added; 'NOTE: Electrical parameters are guaranteed ...'.   | 9/17/12 |
|                        |           | 10         | Added Recommendation for Unused Input and Output Pins section,   |         |
|                        | T8        | 14         | Updated the 'Wiring the Differential Input to Accept Single Ended Levels'<br>Deleted Quantity from Shipping Packaging            |         |

**ICS8305I**

LOW SKEW, 1-TO-4, MULTIPLEXED DIFFERENTIAL/  
LVCMOS-TO-LVCMOS/LVTTL FANOUT BUFFER

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